Notice of References Cited Application/Control No. 10/035,789 Examiner Kiley Stoner Applicant(s)/Patent Under Reexamination PECK, BILL J. Art Unit Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0020515	02-2004	Tolosko et al.	134/21
	В	US-2003/0232343	12-2003	Leproust et al.	435/6
	С	US-2003/0232140	12-2003	Remick et al.	427/294
	D	US-2003/0228422	12-2003	Bass et al.	427/407.1
	E	US-2003/0156989	08-2003	Safir et al.	422/99
	F	US-2003/0118718	06-2003	Hilson et al.	427/2.11
	G	US-2003/0118717	06-2003	Peck, Bill J.	427/2.11
	Н	US-2003/0118716	06-2003	Bass et al.	427/2.11
		US-2003/0118482	06-2003	Peck, Bill J.	422/99
	J	US-2003/0069411	04-2003	Brennan, Thomas M.	536/25.3
	К	US-2001/0010916	08-2001	Schleifer et al.	435/6
-	L	US-2004/0045435	03-2004	Golner et al.	095/117
	М	US-2003/0170148	09-2003	McEntee et al.	422/102

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
		Country Code-Number-Kind Code	IVIIVI- T T T T	· ·		
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U	Perry's Chemical Engineer's Handbook, Sixth Edition, 1984, (5-6).					
	٧						
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/035,789 Examiner Kiley Stoner Applicant(s)/Patent Under Reexamination PECK, BILL J. Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0170148	09-2003	McEntee et al.	422/102
	В	US-2001/0022950	09-2001	Hall et al.	422/131
	С	US-6,372,483	04-2002	Schleifer et al.	435/287.1
	D	US-6,242,266	06-2001	Schleifer et al.	436/518
	E	US-5,641,457	06-1997	Vardanega et al.	422/82.01
	F	US-6,730,517	05-2004	Koster et al.	436/47
	G	US-6,746,649	06-2004	McEntee, John F.	422/102
	Н	US-6,656,432	12-2003	Hirota et al.	422/100
	ı	US-4,981,785	01-1991	Nayak, P. Narayan	435/7.94
	J	US-6,713,023	03-2004	Bass et al.	422/102
	к	US-6,001,311	12-1999	Brennan, Thomas M.	422/131
	L	US-5,658,540	08-1997	Valentino, Joseph V.	423/210
	М	US-5,612,006	03-1997	Fisk, James C.	422/171

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
,	U	
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/035,789 Examiner Kiley Stoner Applicant(s)/Patent Under Reexamination PECK, BILL J. Art Unit Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,981,785	01-1991	Nayak, P. Narayan	435/7.94
	В	US-5,529,756	06-1996	Brennan, Thomas M.	422/131
	С	US-5,472,672	12-1995	Brennan, Thomas M.	422/131
	D	US-5,322,799	06-1994	Miller et al.	436/165
	E	US-5,103,742	04-1992	Valentino, Joseph V.	110/215
	F	US-4,714,541	12-1987	Buyan et al.	208/161
	G	US-3,973,916	08-1976	Shelton, Everett E.	422/174
	Н	US-			
	ı	US-			
	J	US-	,		
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					110
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

		HOW I WILLIAM DOGULATION TO THE PARTY OF THE
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.